

30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor Rev. 01 — 19 April 2010

**Product data sheet** 

### 1. Product profile

### 1.1 General description

NPN low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistor, encapsulated in an ultra thin SOT1061 leadless small Surface-Mounted Device (SMD) plastic package with medium power capability.

PNP complement: PBSS5330PA.

### **1.2 Features and benefits**

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors
- Exposed heat sink for excellent thermal and electrical conductivity
- Leadless small SMD plastic package with medium power capability

### 1.3 Applications

- Loadswitch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

### 1.4 Quick reference data

#### Table 1.Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	30	V
I <sub>C</sub>	collector current		-	-	3	А
I <sub>CM</sub>	peak collector current	single pulse; $t_p \leq 1 ms$	-	-	5	А
R <sub>CEsat</sub>	collector-emitter saturation resistance	I <sub>C</sub> = 3 A; I <sub>B</sub> = 300 mA	<u>[1]</u> _	75	100	mΩ



30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 2. Pinning information

Table 2.	Pinning	
Pin	Description	Simplified outline Graphic symbol
1	base	
2	emitter	3
3	collector	
		1 2 sym021
		Transparent top view

### 3. Ordering information

Table 3. Ordering information				
Type number	Package			
	Name	Description	Version	
PBSS4330PA	HUSON3	plastic thermal enhanced ultra thin small outline package; no leads; three terminals; body $2 \times 2 \times 0.65$ mm	SOT1061	

### 4. Marking

Table 4.	Marking codes	
Type num	iber	Marking code
PBSS433	0PA	AH

### 5. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

			-		
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CBO</sub>	collector-base voltage	open emitter	-	50	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	30	V
V <sub>EBO</sub>	emitter-base voltage	open collector	-	6	V
I <sub>C</sub>	collector current		-	3	А
I <sub>CM</sub>	peak collector current	single pulse; $t_p \leq 1 ms$	-	5	А
I <sub>B</sub>	base current		-	500	mA
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$	<u>[1]</u> -	500	mW
			[2] _	1	W
			<u>[3]</u> _	1.25	W
			[4] _	2.1	W

#### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

#### Table 5. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

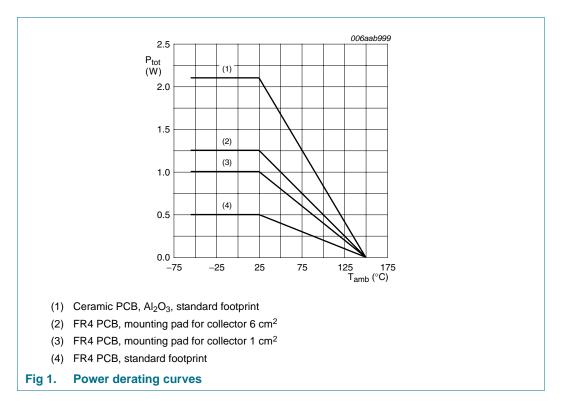
Symbol	Parameter	Conditions	Min	Max	Unit
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-55	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

[4] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



### 6. Thermal characteristics

Thermal characteristics					
Parameter	Conditions	Min	Тур	Max	Unit
thermal resistance from	in free air	<u>[1]</u> _	-	250	K/W
junction to ambient		[2] _	-	125	K/W
		[3]	-	100	K/W
		[4]	-	60	K/W
	Parameter	ParameterConditionsthermal resistance fromin free air	ParameterConditionsMinthermal resistance from junction to ambientin free air[1]-[2]-[3]-	ParameterConditionsMinTypthermal resistance from junction to ambientin free air[1][2][3]	ParameterConditionsMinTypMaxthermal resistance from junction to ambientin free air[1]250[2]125[3]100

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

[4] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.

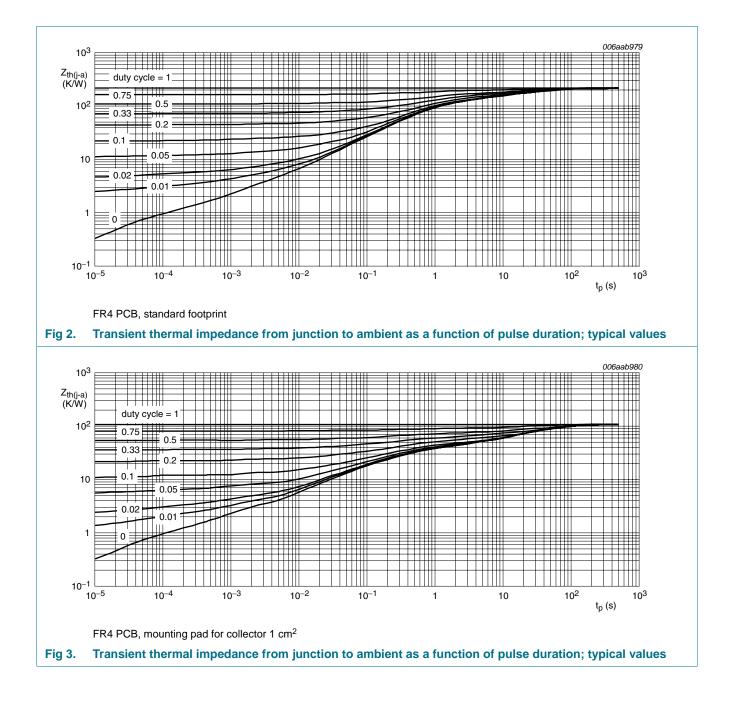
PBSS4330PA 1

3 of 15

#### **NXP Semiconductors**

## PBSS4330PA

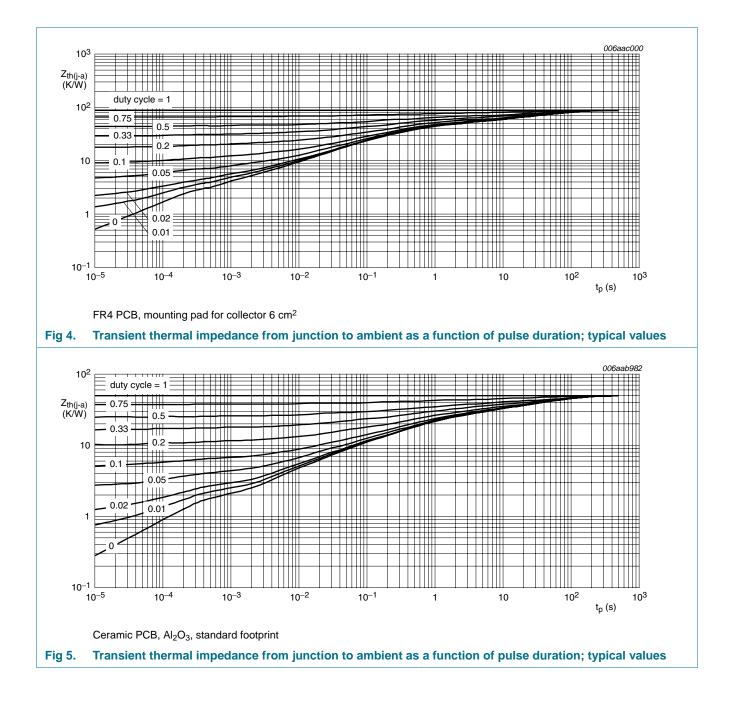
#### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor



#### **NXP Semiconductors**

# PBSS4330PA

#### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor



30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

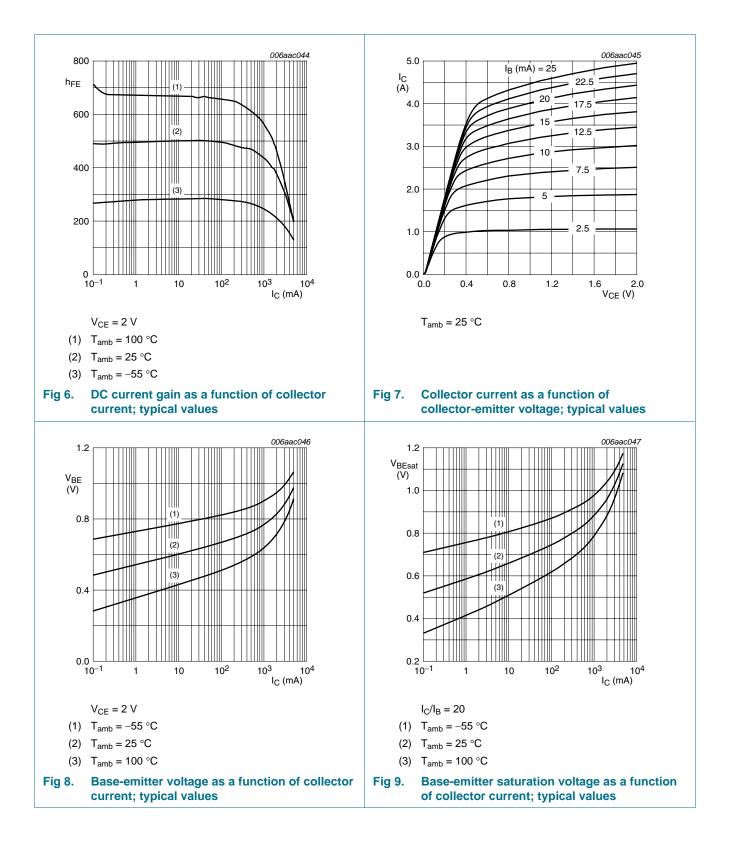
## 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>CBO</sub>	collector-base	$V_{CB} = 30 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
Cul	cut-off current	$V_{CB} = 30 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$	-	-	50	μA
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = 30 \text{ V};  V_{BE} = 0 \text{ V}$	-	-	100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = 2 V$	<u>[1]</u>			
		$I_{\rm C} = 0.5  {\rm A}$	300	465	-	
		I <sub>C</sub> = 1 A	270	435	700	
		I <sub>C</sub> = 2 A	230	370	-	
		I <sub>C</sub> = 3 A	180	310	-	
V <sub>CEsat</sub>	collector-emitter	$I_{C} = 0.5 \text{ A}; I_{B} = 50 \text{ mA}$	<u>[1]</u> -	40	60	mV
	saturation voltage	$I_{C} = 1 \text{ A}; I_{B} = 50 \text{ mA}$	<u>[1]</u> -	80	110	mV
		$I_{C} = 2 \text{ A}; I_{B} = 100 \text{ mA}$	<u>[1]</u> -	155	220	mV
		$I_{C} = 3 \text{ A}; I_{B} = 300 \text{ mA}$	<u>[1]</u> _	220	300	mV
R <sub>CEsat</sub>	collector-emitter saturation resistance	I <sub>C</sub> = 3 A; I <sub>B</sub> = 300 mA	<u>[1]</u> _	75	100	mΩ
V <sub>BEsat</sub>	base-emitter	I <sub>C</sub> = 2 A; I <sub>B</sub> = 100 mA	<u>[1]</u> -	0.95	1.1	V
	saturation voltage	I <sub>C</sub> = 3 A; I <sub>B</sub> = 300 mA	<u>[1]</u> -	1.07	1.2	V
V <sub>BEon</sub>	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 1 \text{ A}$	<u>[1]</u> _	0.76	1	V
t <sub>d</sub>	delay time	$V_{CC} = 9 V; I_C = 2 A;$	-	11	-	ns
t <sub>r</sub>	rise time	I <sub>Bon</sub> = 0.1 A; I <sub>Boff</sub> = -0.1 A	-	52	-	ns
t <sub>on</sub>	turn-on time	$I_{Boff} = -0.1 A$	-	63	-	ns
t <sub>s</sub>	storage time		-	230	-	ns
t <sub>f</sub>	fall time		-	40	-	ns
t <sub>off</sub>	turn-off time		-	270	-	ns
f <sub>T</sub>	transition frequency	$V_{CE} = 5 \text{ V}; I_{C} = 100 \text{ mA};$ f = 100 MHz	100	210	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	21	30	pF

 $\label{eq:point} \begin{tabular}{ll} \end{tabular} \end{tabular} \begin{tabular}{ll} \end{tabular} 1 \end{tabular} \end{tabular} \end{tabular} \end{tabular} \begin{tabular}{ll} \end{tabular} \end{tabular} \end{tabular} \end{tabular} \begin{tabular}{ll} \end{tabular} \end{tabular}$ 

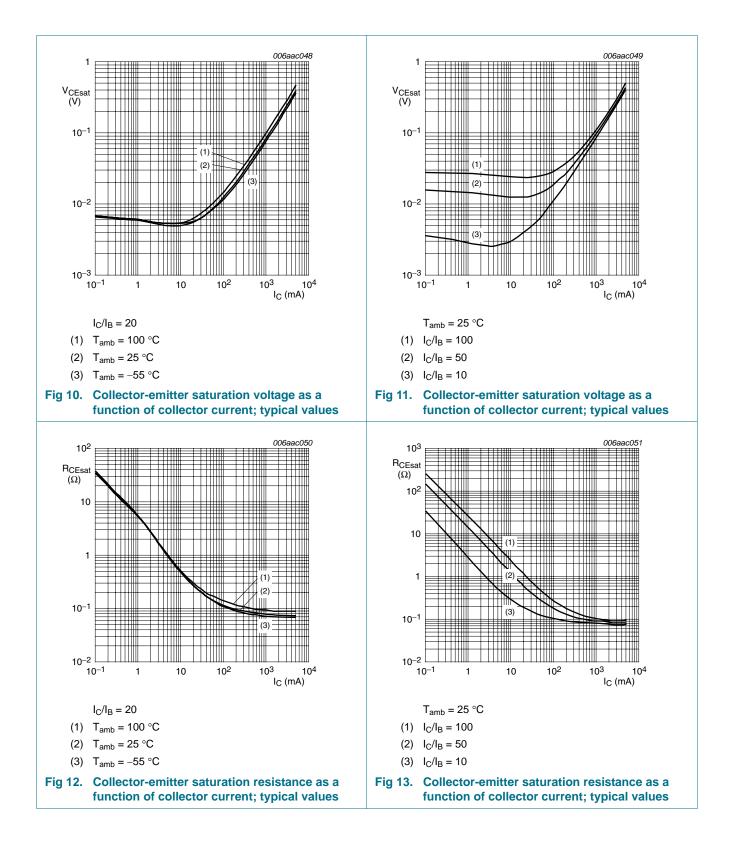
PBSS4330PA\_1 Product data sheet

#### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor



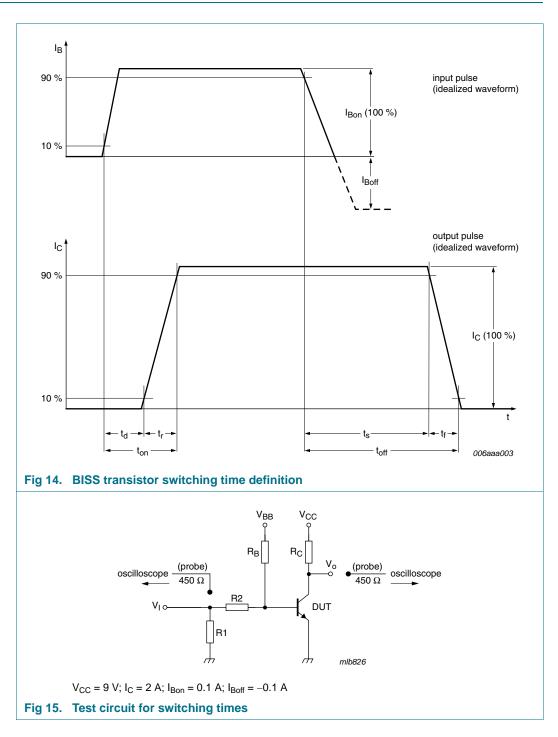
Product data sheet

#### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor



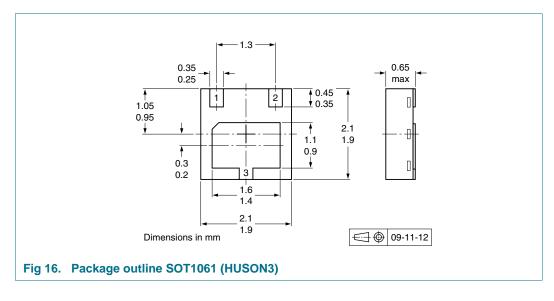
30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

## 8. Test information



30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 9. Package outline



### **10. Packing information**

#### Table 8. Packing methods

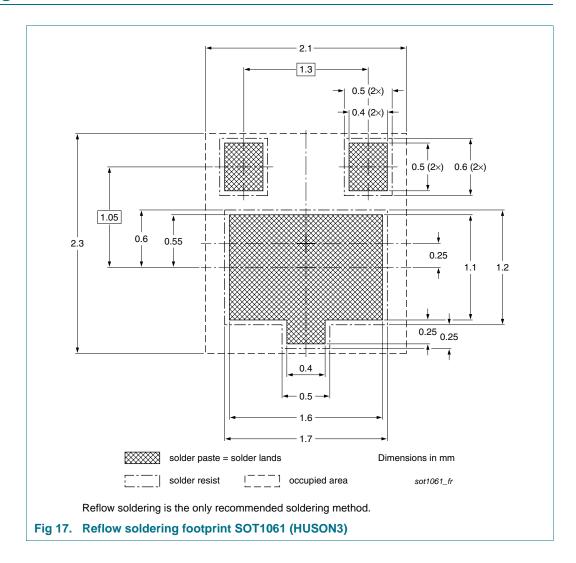
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing quantity
			3000
PBSS4330PA	SOT1061	4 mm pitch, 8 mm tape and reel	-115

[1] For further information and the availability of packing methods, see <u>Section 14</u>.

### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

### **11. Soldering**



PBSS4330PA\_1 Product data sheet

30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

## **12. Revision history**

Table 9. Revision hist	Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes	
PBSS4330PA_1	20100419	Product data sheet	-	-	

#### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 13. Legal information

#### 13.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

#### 13.2 Definitions

**Draft** — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

**Product specification** — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

### 13.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

**Applications** — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <a href="http://www.nxp.com/profile/terms">http://www.nxp.com/profile/terms</a>, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

**No offer to sell or license** — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

**Export control** — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

#### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

**Quick reference data** — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

**Non-automotive qualified products** — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the

### 14. Contact information

product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

### 13.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

### 30 V, 3 A NPN low V<sub>CEsat</sub> (BISS) transistor

### **15. Contents**

1	Product profile 1
1.1	General description 1
1.2	Features and benefits1
1.3	Applications 1
1.4	Quick reference data 1
2	Pinning information 2
3	Ordering information 2
4	Marking 2
5	Limiting values 2
6	Thermal characteristics 3
7	Characteristics
8	Test information 9
9	Package outline 10
10	Packing information 10
11	Soldering 11
12	Revision history 12
13	Legal information 13
13.1	Data sheet status 13
13.2	Definitions
13.3	Disclaimers
13.4	Trademarks 14
14	Contact information 14
15	Contents 15

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2010.

All rights reserved.

For more information, please visit: http://www.nxp.com For sales office addresses, please send an email to: salesaddresses@nxp.com

Date of release: 19 April 2010 Document identifier: PBSS4330PA\_1